

Device Modeling Report

COMPONENTS: BIPOLAR JUNCTION TRANSISTOR
PART NUMBER: 2SC3153
MANUFACTURER: SANYO



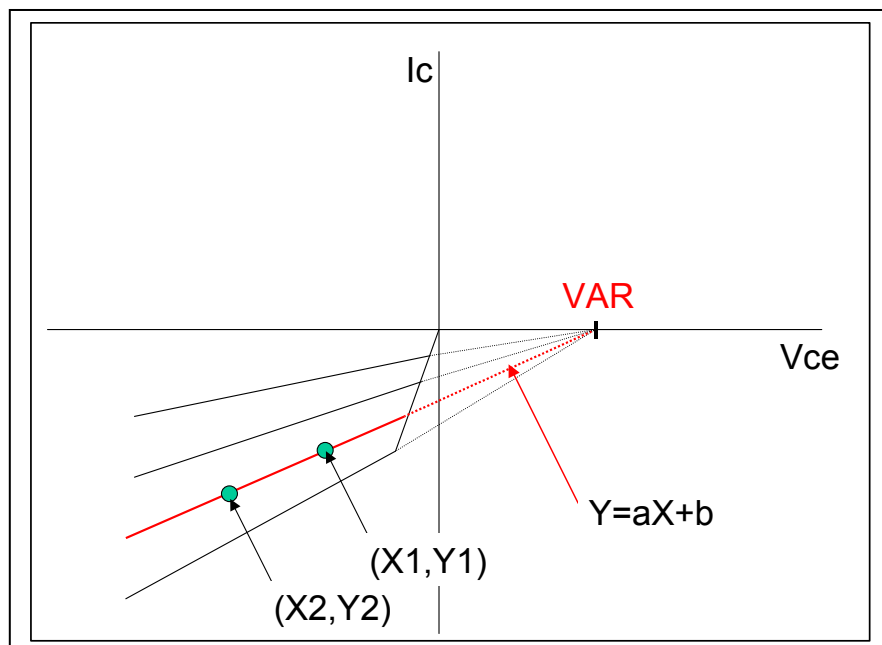
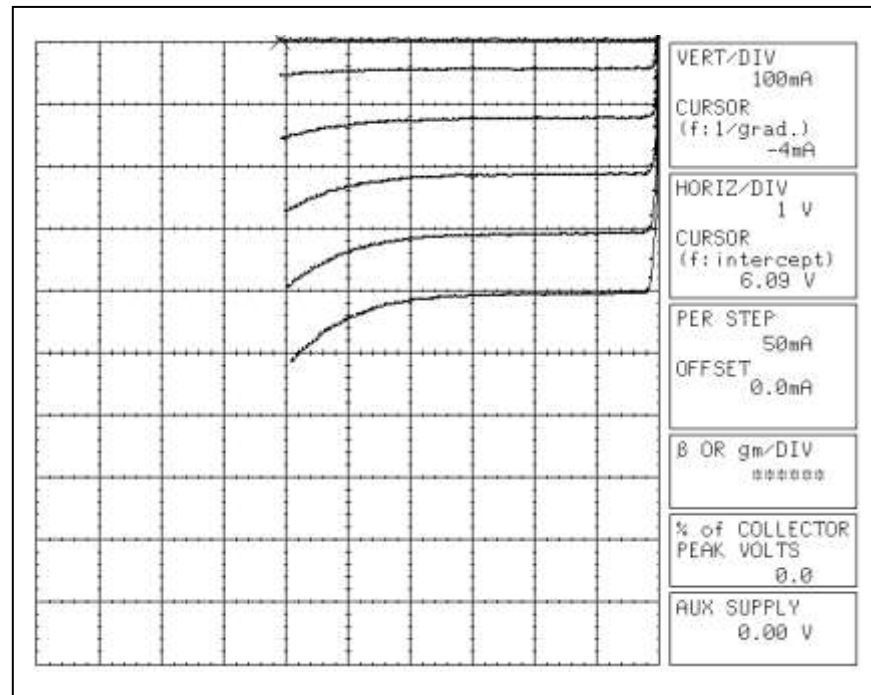
Bee Technologies Inc.

SPICE MODEL

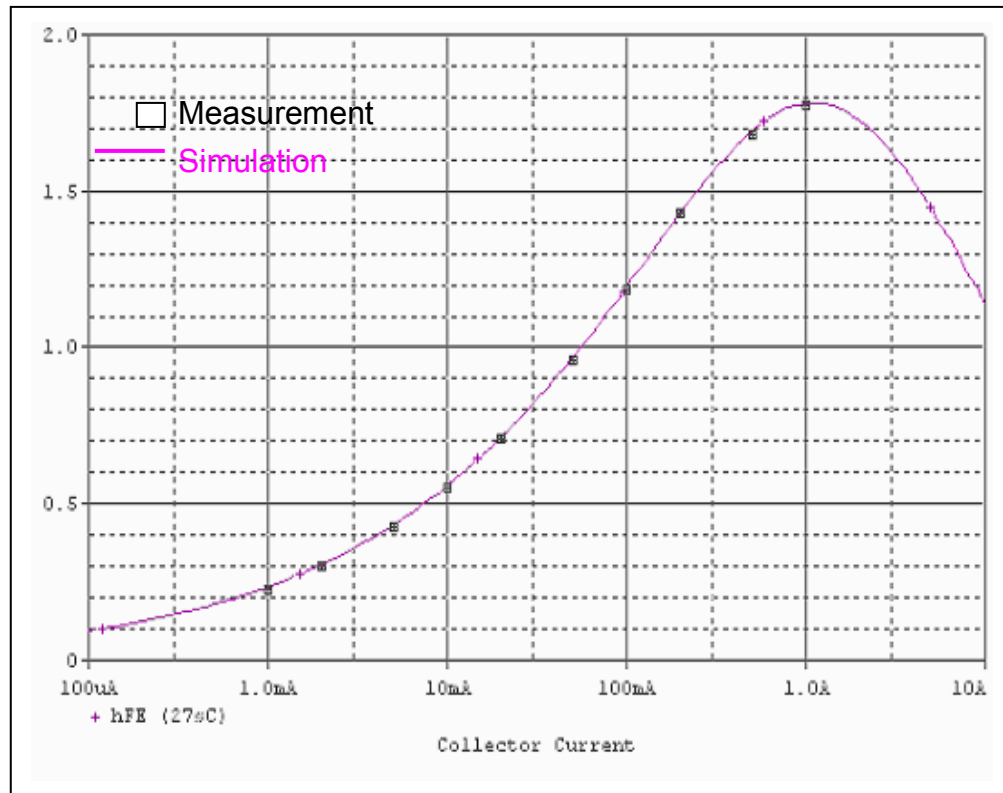
PSpice model parameter	Model description
IS	Saturation Current
BF	Ideal Maximum Forward Beta
NF	Forward Current Emission Coefficient
VAF	Forward Early Voltage
IKF	Forward Beta Roll-off Knee Current
ISE	Non-ideal Base-Emitter Diode Saturation Current
NE	Non-ideal Base-Emitter Diode Emission Coefficient
BR	Ideal Maximum Reverse Beta
NR	Reverse Emission Coefficient
VAR	Reverse Early Voltage
IKR	Reverse Beta Roll-off Knee Current
ISC	Non-ideal Base-Collector Diode Saturation Current
NC	Non-ideal Base-Collector Diode Emission Coefficient
NK	Forward Beta Roll-off Slope Exponent
RE	Emitter Resistance
RB	Base Resistance
RC	Series Collector Resistance
CJE	Zero-bias Emitter-Base Junction Capacitance
VJE	Emitter-Base Junction Potential
MJE	Emitter-Base Junction Grading Coefficient
CJC	Zero-bias Collector-Base Junction Capacitance
VJC	Collector-base Junction Potential
MJC	Collector-base Junction Grading Coefficient
FC	Coefficient for Onset of Forward-bias Depletion Capacitance
TF	Forward Transit Time
XTF	Coefficient for TF Dependency on Vce
VTF	Voltage for TF Dependency on Vce
ITF	Current for TF Dependency on Ic
PTF	Excess Phase at $f=1/2\pi \cdot TF$
TR	Reverse Transit Time
EG	Activation Energy
XTB	Forward Beta Temperature Coefficient
XTI	Temperature Coefficient for IS

Reverse

Reverse Early Voltage Characteristic

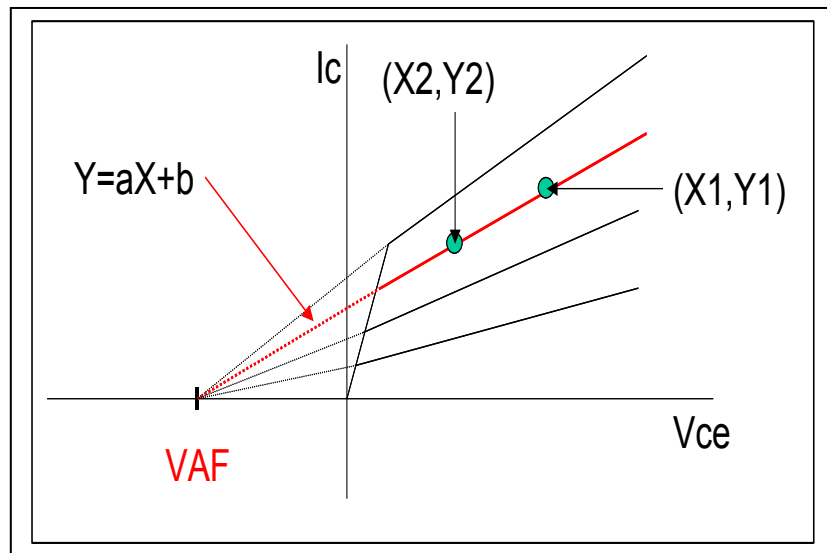
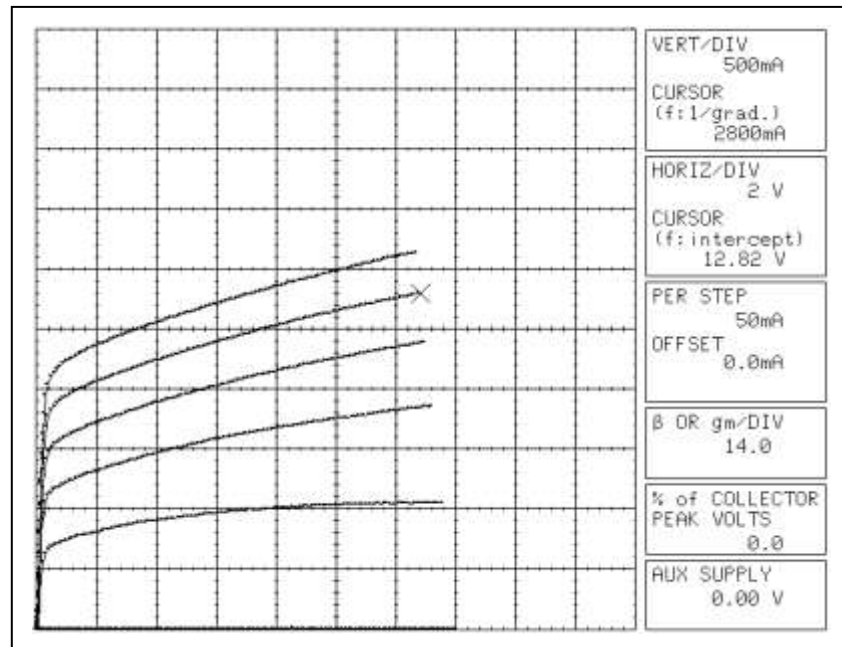


Reverse DC Beta Characteristic (I_e vs. h_{FE})

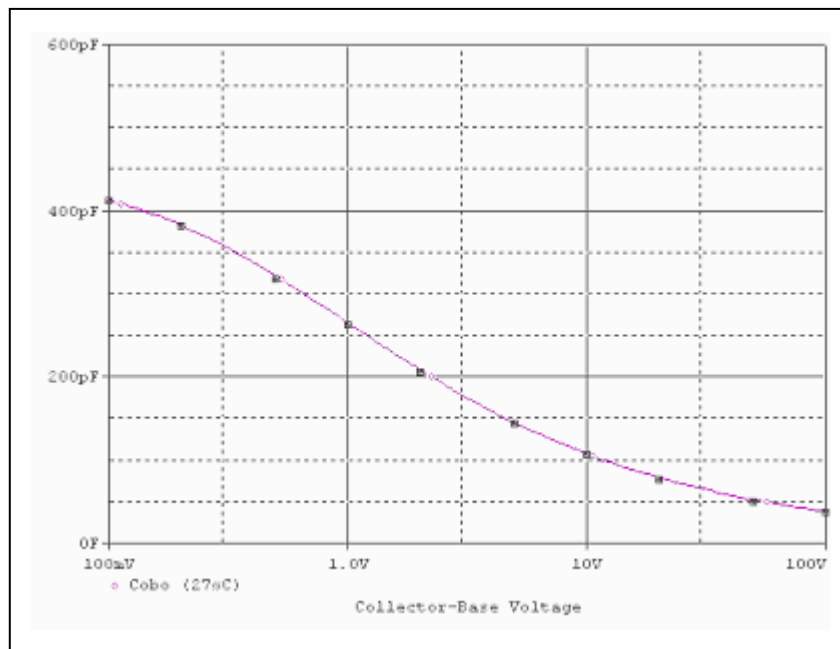


Forward

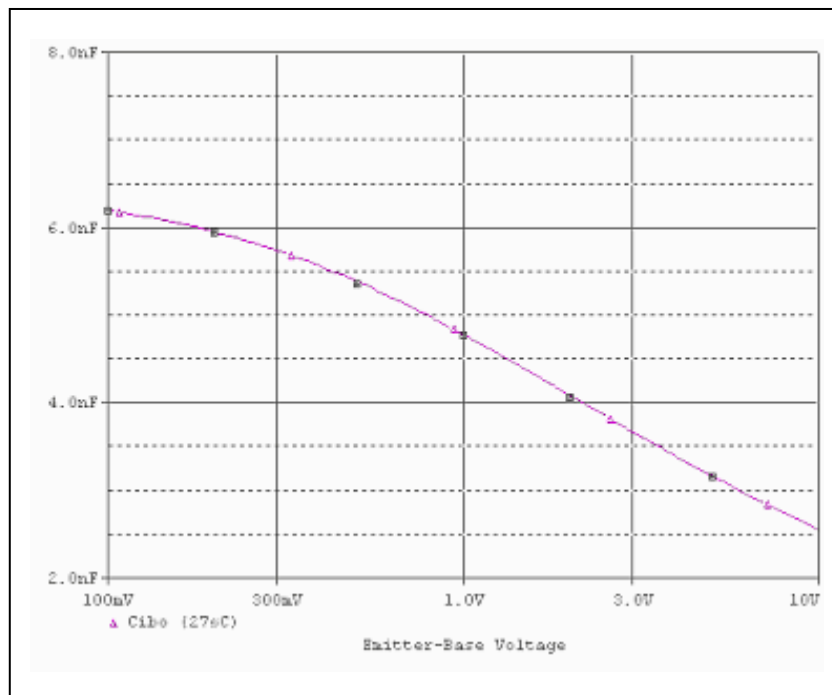
Forward Early Voltage Characteristic



C-B Capacitance Characteristic

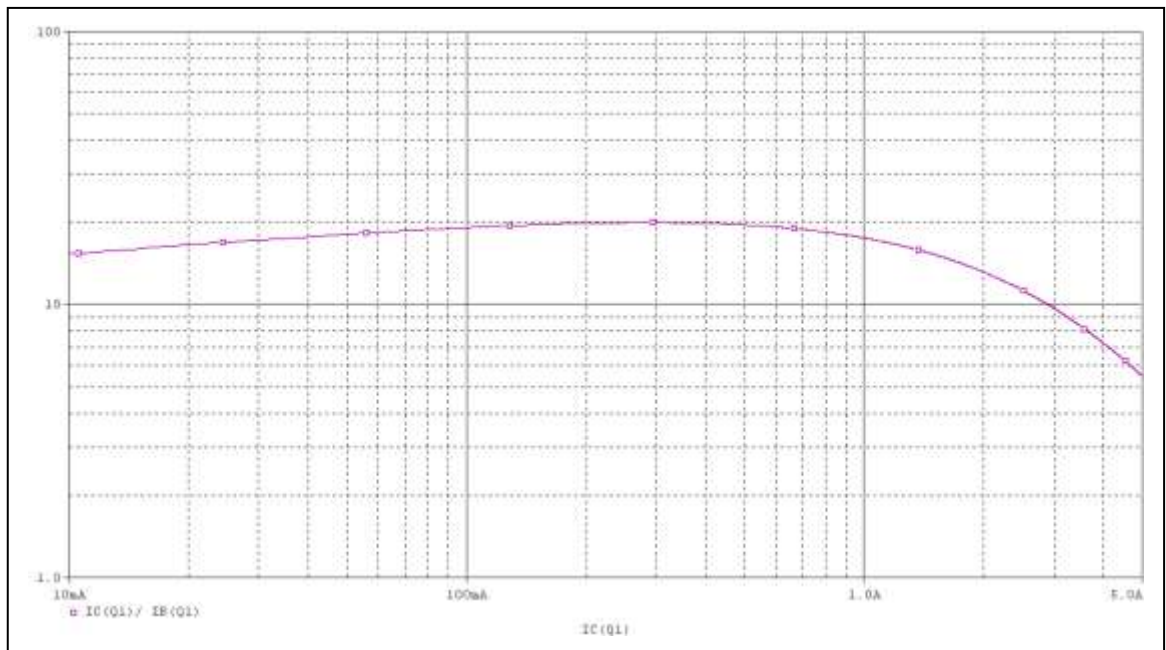


E-B Capacitance Characteristic

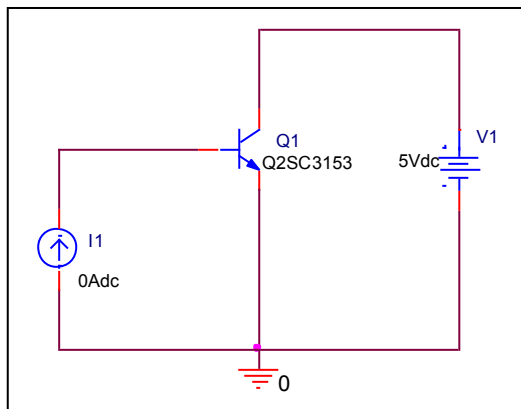


BJT Ic-hFE Characteristics

Circuit simulation result

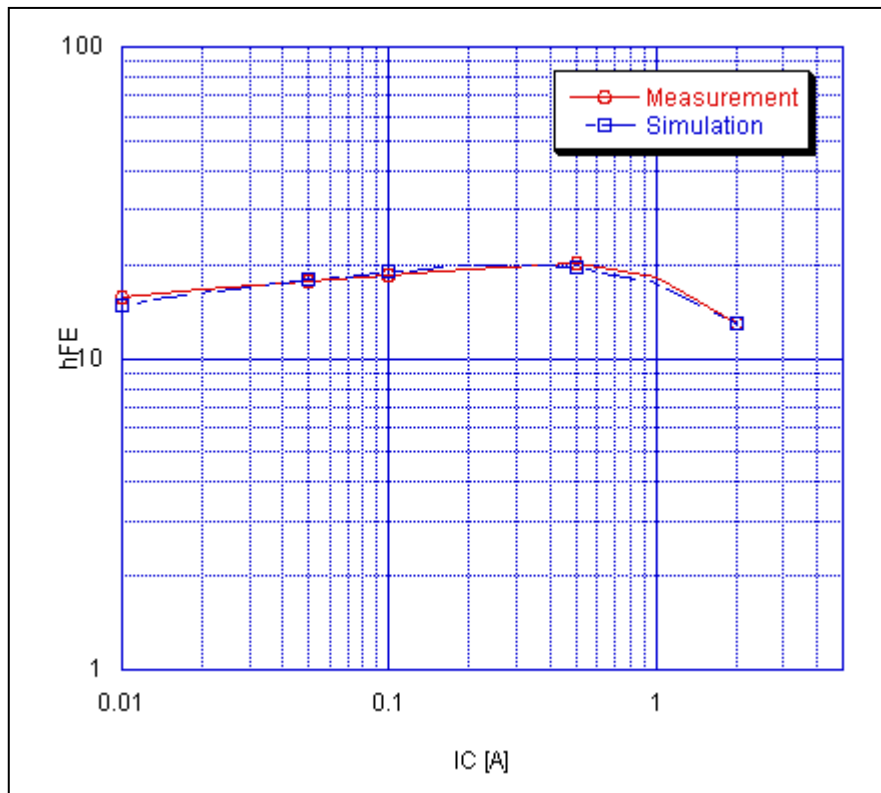


Evaluation circuit



Comparison Graph

Circuit simulation result

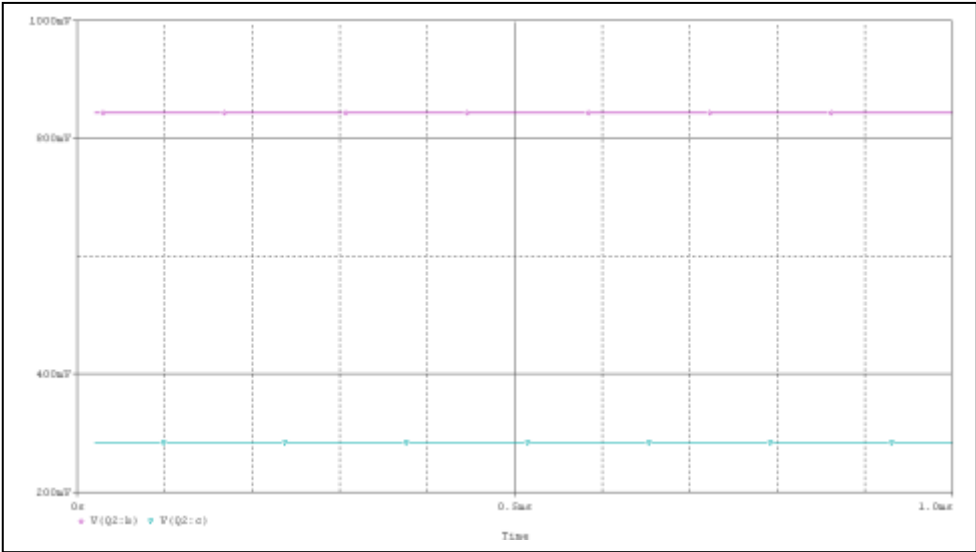


Simulation result

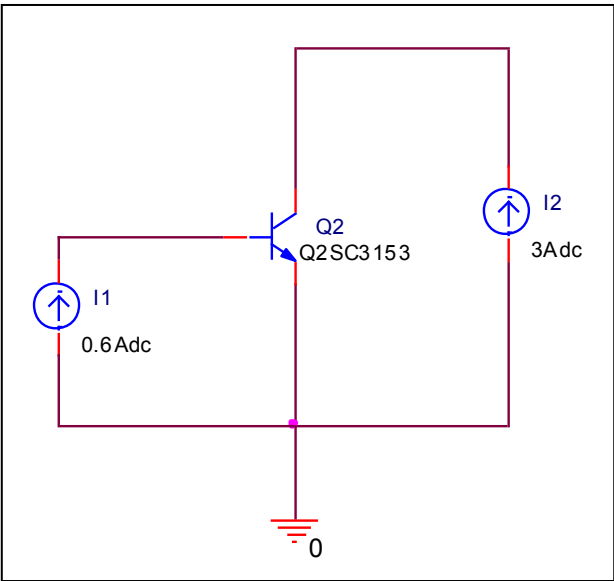
Ic(A)	hFE		%Error
	Measurement	Simulation	
0.01	15.625	14.878	4.7808
0.02	16.598	16.176	2.542475
0.05	17.73	17.92	1.07163
0.1	18.587	19.08	2.652391
0.2	19.417	19.896	2.46691
0.5	20.161	19.62	2.683399
1	18.215	17.45	4.199835
2	12.92	12.88	0.309598

BJT Vce(sat) voltage & Vbe(sat) voltage Characteristics

Circuit simulation result



Evaluation circuit



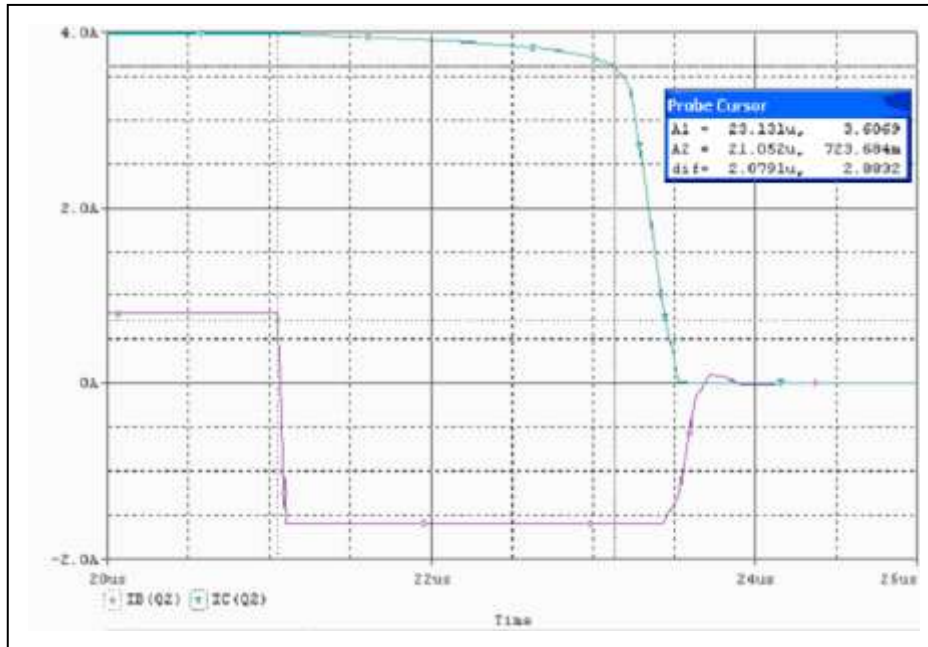
Simulation result

Test condition: $I_C/I_B = 5$, $I_C=3A$

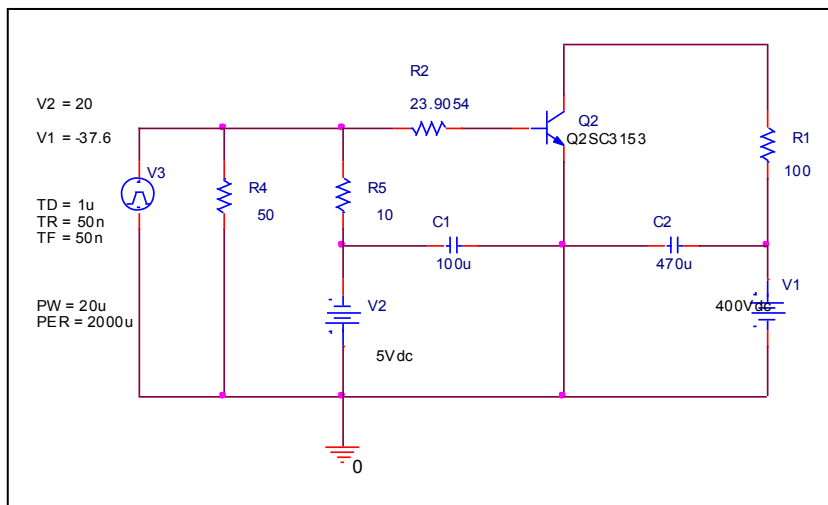
Vce(sat)(V)			Vbe(sat)(V)		
Measurement	Simulation	Error(%)	Measurement	Simulation	Error(%)
0.28	0.283	1.0714	0.85	0.843	0.8235

Switching Characteristics

Circuit simulation result



Evaluation circuit

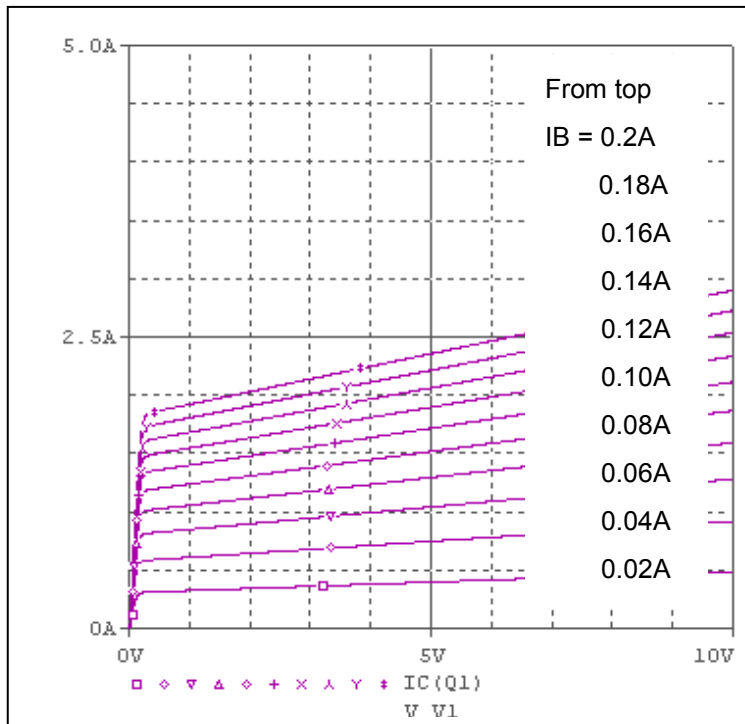


Simulation result

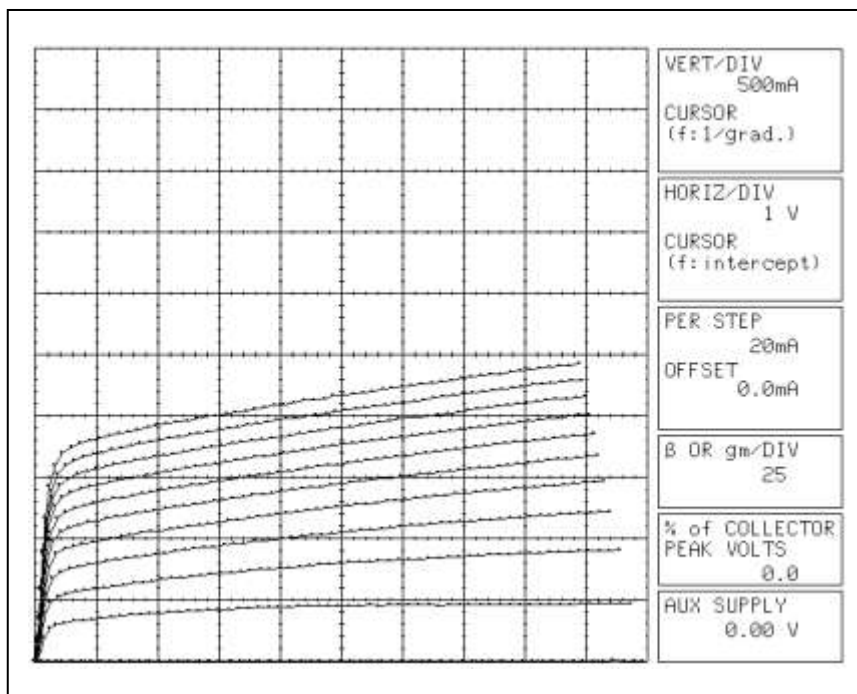
Ts(us)			Tf(us)	
Measurement	Simulation	%Error	Measurement	Simulation
2.05	2.0791	1.4195	0.7[max.]	0.348609

Output Characteristics

Circuit simulation result



Measurement result



Evaluation circuit

